

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/694,329	SVENSON, RICHARD NEAL	
		Examiner	Art Unit	Page 1 of 1
		Niki M. Eloshway	3727	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0080125	05-2003	Cassani, Julius John	220/6
*	B	US-4,014,292	03-1977	Coughlin et al.	119/168
*	C	US-3,376,994	04-1968	FLINN JR JOSEPH A	220/6
*	D	US-1,202,253	10-1916	Vitt	220/6
*	E	US-846,788	03-1907	Friedheim	229/117.04
*	F	US-810,574	01-1906	Sewell	229/117.02
*	G	US-6,149,025	11-2000	Wang, Wen-Tsan	220/6
*	H	US-5,472,107	12-1995	Lieber, John H.	220/6
*	I	US-6,588,652	07-2003	Cai, Liming	229/117.07
*	J	US-6,543,679	04-2003	Cai et al.	229/120.06
*	K	US-5,335,845	08-1994	Liu, Yuan-Hsin	229/120.18
*	L	US-6,253,943	07-2001	Spykerman et al.	220/6
*	M	US-6,015,071	01-2000	Adomeit et al.	224/42.34

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.